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Continuous-wave lasing between Landau levels in graphene

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We predict the general feasibility and demonstrate the design of the continuous-wave terahertz laser operating between Landau levels in graphene placed on a polar substrate in a magnetic field of order 1 T. Steady-state population inversion under a continuous-wave optical pumping becomes possible due to surface-phonon-mediated relaxation of carriers. The scheme is scalable to other materials with massless Dirac fermions, for example, surface states in three-dimensional topological insulators such as Bi_2Se_3 or Bi_2Te_3 .

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I. INTRODUCTION

Free nonrelativistic electrons in a magnetic field behave as a system of harmonic oscillators, with selection rules allowing only the transitions between neighboring states with equal probabilities. Therefore they cannot be used as an active medium for lasers and masers. One way to get around this limitation is to accelerate electrons to high enough speeds that the relativistic effects become important. This leads to an anharmonicity in the electron spectrum and possibility of the maser action by accelerated electron beams, which has been so impressively implemented in vacuum electronic devices such as gyrotrons [1]. Free carriers in semiconductors seem to offer a similar opportunity as the electron dispersion can show significant nonparabolicity above the bottom of the conduction band. Moreover, semiconductors offer a flexibility to grow heterostructures with different cyclotron transition energies which could be used for carrier injection into a given Landau level (LL); see the proposal for a LL laser in the quantum Hall regime [2]. In practice, however, ultrafast energy and momentum relaxation in semiconductors would quickly destroy population inversion between the LLs. Although Landau level quantization does help with reducing scattering rate and improving the performance of quantum cascade lasers [3] that operate through population inversion between quantum-well subbands, the only "solid-state gyrotrons" so far are p-Ge lasers operating between light-hole LLs at liquid helium temperatures in strong electric and magnetic fields [4,5].

Graphene seems to be an ideal material for the realization of LL lasers. Low-energy excitations near the Dirac points in graphene have a linear conical spectrum which is obviously extremely nonparabolic. In a transverse magnetic field the two-dimensional (2D) conical spectrum splits into a series of nonequidistant LLs with energies scaling as a square root of the magnetic field and the principal quantum number. It was suggested in [6] that the optical pumping to an arbitrary excited state $n \geqslant 1$ will lead to electrons cascading down the LLs preferentially emitting photons, which would potentially lead to the EM field amplification on any of these downward transitions. Unfortunately, the proposal [6] assumed that the radiative transitions are the fastest ones in

graphene. It did not include the most important nonradiative relaxation channels and did not attempt to calculate actual LL populations. In particular, it turns out that the Auger relaxation is a very powerful relaxation mechanism for Dirac electrons in a magnetized graphene that proceeds much faster than radiative transitions and washes out any population inversion over the time scale of a few picoseconds; see below and also recent theoretical calculations of the Auger relaxation rate [7] and experimental measurements in [8]. A recently proposed, more sophisticated pumping scheme [9] takes into account Auger relaxation processes and still leads to only a transient population inversion existing over a picosecond time scale.

Here we propose what we believe is a viable LL laser scheme for graphene that takes into account all relevant relaxation processes and in fact utilizes them to reach a steady-state population inversion, vital for any viable laser. Our scheme is transferable to thin ($\lambda \gg \Delta z \geqslant 5$ nm) films of three-dimensional (3D) topological insulators such as Bi₂Se₃, where the Landau levels associated with massless metallic surface states [10,11] should demonstrate similar coupling to the EM field, despite different chirality [12]. Note that our scheme provides the population inversion *in a steady state*, i.e., under a continuous-wave pumping, in contrast to previous proposals, with or without the magnetic field, that could provide only a transient gain during a picosecond time interval [6,9,13].

We solve kinetic and density matrix equations coupled with Maxwell's equations to calculate populations, gain, and laser threshold conditions as a function of the optical pumping power. The calculation details are in the sections below. Here we present a general idea of the laser scheme. It is illustrated in Fig. 1. It shows one specific implementation of the scheme with an optical pumping originating from level n = -2 to obtain maximum population inversion between levels -1 and -2. However, the scheme can be implemented for any pair of LLs (-n, -n - 1) as long as level -n stays deep enough below the Fermi level. The lasing wavelength can be from subterahertz to the midinfrared range, depending on the value of n, the magnetic field, and the substrate used.

The general idea is as follows. In the equilibrium (without pumping) levels n=-1 and -2 are fully occupied to a degeneracy surface density $N_s=g_sg_v/2\pi l_c^2$, where spin and valley degeneracy factors are $g_s=2$ and $g_v=2$ for graphene, and $l_c=\sqrt{c\hbar/eB}$ is the magnetic length. The Fermi level is placed at the Dirac point in the figure, assuming intrinsic

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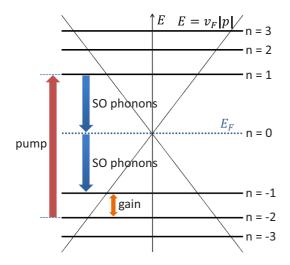


FIG. 1. (Color online) The scheme to obtain population inversion between the electron states below the Fermi level by using a continuous-wave optical pumping. Electrons excited by a pump preferentially relax to the upper laser state -1 due to resonant emission of surface optical phonons at the graphene-substrate interface.

graphene. However, this can be changed, as long as level n = -1 is fully occupied in equilibrium. An optical pumping resonant to the transition $-2 \rightarrow 1$ moves part of the carriers up from level n = -2, creating a population inversion between a fully occupied level n = -1 and level -2. In order for this population inversion to exist in a steady state, i.e., under a continuous-wave optical pumping, the relaxation of carriers back to lower laser state -2 should be slower than the relaxation rate to the upper laser state -1. Unfortunately, the Auger mechanism does not satisfy this criterion. Our simulations show that there is no population inversion in the steady state, no matter how strong the optical pumping power. This is because an increase in the depopulation rate of level -2 by an optical pumping is compensated by an increase in the Auger scattering rate to level 2, primarily through the scattering of electrons from states in levels 1 and -1 to states in levels 2 and -2, respectively. In order to overcome this obstacle, the magnetic field needs to be tuned in order to bring the transitions $1 \rightarrow 0$ and $0 \rightarrow -1$ (of the same energy) in resonance with an LO phonon energy. This will greatly increase the rate of electron relaxation from excited states to the upper laser state n = -1 through LO phonon emission, whereas the transitions to state -2 will be out of resonance and not affected much.

The LO phonon energy in graphene is close to 200 meV, which would require a magnetic field of almost 30 T to bring the transition frequency ω_{10} close to ω_{LO} . In order to reduce the required magnetic field, one can utilize the scattering on bulk, surface, or interface optical phonons of the substrate and choose the substrate with a lower optical phonon energy, for example, a polar semiconductor such as GaAs or InGaAs [14]. For definiteness, below we assume the substrate to be GaAs, which leads to the surface optical (SO) phonon energy of $\hbar\omega_{SO}=36$ meV [15]. This is equal to $\omega_{01}=\omega_c=\sqrt{2}v_f/l_c$ in a magnetic field of 1 T. The laser transition wavelength would be then around 82 μ m, i.e., around 3 THz, which is

the range where there is a shortage of laser sources. We will also assume the optical pumping between levels -2 and 1, although the pumping resonant to the transition from -2 to 3 would be equally efficient and lead to a similar value for the gain. Moreover, the transition frequency for the latter transition in a magnetic field of 1 T would correspond to a CO_2 laser wavelength of around $10~\mu m$, which could be more convenient than the 14- μm wavelength corresponding to the transition $-2 \rightarrow 1$. Of course, all energies can be changed as needed by choosing different substrates or different LLs for the lower laser state, for example, n=-3 instead of -2.

The scheme in Fig. 1 provides population inversion between hole states -1 and -2. Its "mirror image" provides a similar population inversion between electron states 1 and 2 when the optical pump is applied between states -1 and 2 [16]. In this case the SO phonons depopulate the lower laser state instead of populating the upper one.

II. ELECTRON STATES AND OPTICAL TRANSITIONS BETWEEN THE LANDAU LEVELS IN GRAPHENE

For completeness, we give a brief summary of the electron states and optical transitions between the LLs in graphene, since this information is extensively used below. They have been calculated many times before and observed both in monolayer and multilayer samples [17].

Neglecting intervalley scattering, we will need electron states in only one of the two equivalent K, K' valleys, for example the K valley. Without a magnetic field, the low-energy Hamiltonian in the vicinity of the \vec{K} Dirac point is given by [18]

$$H = v_F \vec{\sigma} \cdot \hat{\vec{p}} = v_F \begin{pmatrix} 0 & \hat{p}_x - i\,\hat{p}_y \\ \hat{p}_x + i\,\hat{p}_y & 0 \end{pmatrix}, \tag{1}$$

where $v_F = 10^8$ cm/s. In the presence of a transverse magnetic field or any EM field described by the vector potential A, we replace \hat{p} with $\hat{\Pi} = \hat{p} + e\vec{A}/c$. For a magnetic field in the +z direction, we can write $\vec{A} = (0, Bx, 0)$ in the Landau gauge, then the eigenfunctions are expressed as [19]

$$F_{nk}^{K}(\vec{r}) = \frac{1}{\sqrt{I}} e^{iky} \Phi_n(k, x), \tag{2}$$

with

$$\Phi_n(k,x) = C_n \begin{pmatrix} \operatorname{sgn}(n)i^{|n|-1}\phi_{|n|-1}(x+l_c^2k) \\ i^{|n|}\phi_{|n|}(x+l_c^2k) \end{pmatrix},$$
(3)

where $C_n = 1$ when n = 0, and $C_n = 1/\sqrt{2}$ when $n \neq 0$; $\operatorname{sgn}(x) = 1, 0, -1$ for x > 0, x = 0, x < 0, respectively. The function $\phi_{|n|}(x)$ has the same form as the eigenfunction in the massive electron case:

$$\phi_{|n|}(x) = \frac{1}{\sqrt{2^{|n|}|n|!\sqrt{\pi l_c}}} \exp\left[-\frac{1}{2} \left(\frac{x}{l_c}\right)^2\right] H_{|n|}\left(\frac{x}{l_c}\right), \quad (4)$$

where $H_{|n|}(x)$ is the Hermite polynomial. The corresponding eigenenergy is $\epsilon_n = \operatorname{sgn}(n)\hbar\omega_c\sqrt{|n|}$, with $\omega_c = \sqrt{2}v_f/l_c$.

In this paper, an electron state will be labeled by $|n,k,s,\xi\rangle$, where $s = \{\uparrow, \downarrow\}$ denotes spin, $\xi = \{K,K'\}$ denotes valley; k, s, ξ are degenerate quantum numbers, and the total degeneracy density of a Landau level n is $2/\pi l_c^2$.

The interaction Hamiltonian for an optical field with an in-plane polarization can be written as

$$\hat{H}_{\rm int}^{\rm op} = v_F \frac{e}{\sigma} \vec{\sigma} \cdot \vec{A}^{\rm op}, \tag{5}$$

where $\vec{A}^{\rm op}$ is the vector potential of the optical field, which is related to the electric field by $\vec{E}^{\rm op} = (-1/c)\partial\vec{A}^{\rm op}/\partial t$. If we define two circular polarization vectors, $\hat{l}_{\oplus} = (\hat{x} + i\,\hat{y})/\sqrt{2}$ and $\hat{l}_{\ominus} = (\hat{x} - i\,\hat{y})/\sqrt{2}$, the vector potential of a single-frequency optical field can be written as

$$\vec{A}^{\text{op}} = \frac{1}{2} (A_{\oplus} \hat{l}_{\oplus} + A_{\ominus} \hat{l}_{\ominus}) e^{-i\omega t} + \text{c.c.}$$
 (6)

Plugging this expression into the Schrödinger equation and using the rotating wave approximation, we get the same selection rules as in [20]: transitions between n_1 and n_2 ($n_2 > n_1$) are coupled by photons with \hat{l}_\oplus polarization if $|n_2| = |n_1| + 1$, and with \hat{l}_\ominus polarization if $|n_2| = |n_1| - 1$. By expressing \hat{A}^{op} through \hat{E}^{op} in $\hat{H}^{\text{op}}_{\text{int}}$, we can get the

By expressing A^{op} through E^{op} in $\hat{H}_{\text{int}}^{\text{op}}$, we can get the magnitude of the dipole moment for a resonant transition between Landau levels n_1 and n_2 :

$$|\mu_{n_1 n_2}| = \sqrt{2} C_{n_1} C_{n_2} e v_F / \omega.$$
 (7)

The two-dimensional linear optical susceptibility near the resonance to the transition between n_1 and n_2 ($n_1 < n_2$) is

$$\chi_{n_1 n_2} = \frac{2}{\pi l_c^2} \frac{\left|\mu_{n_1 n_2}\right|^2 (f_{n_2} - f_{n_1})}{\hbar \omega - (\epsilon_{n_2} - \epsilon_{n_1}) + i \hbar / T_2},\tag{8}$$

where T_2 is the phenomenological dephasing time, which we take to be equal to 100 fs. It is strongly affected by disorder. The gain at resonance scales $\propto T_2$ so it is important to maximize this time. The factors f in the numerator are occupation numbers of given Landau levels. The optical transition rate between n_1 and n_2 ($n_1 < n_2$) is

$$\Gamma_{n_1 n_2}^{\text{op}} = \frac{1}{2} \left| \frac{\mu_{n_1 n_2} E^{\text{op}}}{\hbar} \right|^2 \frac{1/T_2}{(1/T_2)^2 + \left[\left(\epsilon_{n_2} - \epsilon_{n_1} \right) / \hbar - \omega \right]^2}. \tag{9}$$

III. LASER THRESHOLD CONDITION

To determine the threshold condition for a LL graphene laser, we consider the simplest geometry resembling a quantum-well vertical-cavity laser, in which an active layer consisting of one or several graphene monolayers on a polar substrate is located between the two mirrors of given reflection factors $r_{1,2}$; see Fig. 2. We will assume that there are two media with dielectric constants κ_1 and κ_2 from both sides of the active layer. We will also assume for simplicity that the thickness of an active layer is much smaller than the wavelength of the terahertz laser field. For a field of amplitude E_i incident on the graphene layer, the amplitudes of reflected and transmitted waves E_r and E_t can be related using the Maxwell's equations

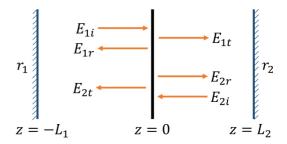


FIG. 2. (Color online) A vertical-cavity configuration of the graphene laser.

with proper boundary conditions as

$$E_{t} = \frac{2}{1 + \sqrt{\frac{\kappa_{2}}{\kappa_{1}}} - \frac{4\pi i \omega}{\sqrt{\kappa_{1}c}} \chi} E_{i},$$

$$E_{r} = \left(\frac{2}{1 + \sqrt{\frac{\kappa_{2}}{\kappa_{1}}} - \frac{4\pi i \omega}{\sqrt{\kappa_{1}c}} \chi} - 1\right) E_{i}.$$
(10)

To make the equations even simpler, we will take $\kappa_1 = \kappa_2 = \kappa$. It is straightforward to include more complex cavity structures if needed for a particular design.

The fields also need to satisfy the boundary conditions at the mirrors:

$$E_{1i}e^{-ikL_1} = r_1(E_{1r} + E_{2t})e^{ikL_1},$$

$$E_{2i}e^{-ikL_2} = r_2(E_{1t} + E_{2r})e^{ikL_2}.$$
(11)

From the boundary conditions Eqs. (10) and (11), the condition to have stable nonzero optical fields inside the cavity is

$$-\frac{2\pi i\omega}{\sqrt{\kappa}c}\chi = \frac{r_1r_2 - e^{-2ik(L_1 + L_2)}}{r_1r_2 + r_1e^{-2ikL_2} + r_2e^{-2ikL_1} + e^{-2ik(L_1 + L_2)}}.$$
(12)

To get the threshold, we assume that the optical fields are in resonance with respective transitions and the lengths L_1 and L_2 are adjusted so that every term in the denominator has the same sign. Then the minimum required imaginary part of the susceptibility in the active layer can be found from the real part of Eq. (12):

$$-\frac{2\pi\omega}{\sqrt{\kappa}c}\text{Im}[\chi] = \frac{1 - |r_1r_2|}{1 + |r_1| + |r_2| + |r_1r_2|}.$$
 (13)

We discuss the feasibility of reaching the lasing threshold below, after calculating the rates of scattering processes, the nonequilibrium populations of the LLs, and the resulting graphene susceptibility at the laser transition in the presence of an optical pumping.

The carriers excited by an optical pumping relax through a variety of scattering processes. The steady-state populations are determined by a balance between relaxation and the continuous-wave pumping. In the next two sections we give a detailed description of the most important processes that determine the redistribution of populations and the resulting steady-state gain.

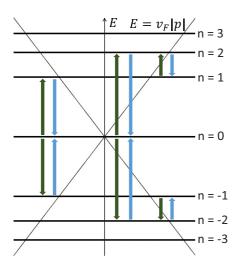


FIG. 3. (Color online) Examples of the Auger scattering processes between $n=0,\pm 1,\pm 2$ LLs.

IV. AUGER PROCESSES

A strong magnetic field suppresses scattering processes due to energy quantization and reduction in the phase space available for scattered carriers. However, Auger processes remain very efficient. Due to the symmetry between electron and hole LLs there is always resonance for scattering of carriers from (0,0) LLs into (1,-1) states and for all other combinations allowed by the energy conservation: $(1,-1) \leftrightarrow (2,-2)$, $(0,0) \leftrightarrow (2,-2)$, $(-1,1) \leftrightarrow (2,-2)$, etc.; see Fig. 3. Recently the Auger relaxation rates were measured to be in a few picoseconds range in pump-probe experiments [8], which agrees with our simulations. Below we outline the general derivation of the Auger scattering rate and then apply it to our problem.

A. General formulas

Auger processes are mediated by the Coulomb interaction between carriers. The general Coulomb interaction Hamiltonian for electrons can be written as [21]

$$V_C = \frac{1}{2} \sum_{\alpha\beta\gamma\delta} V_{\alpha\beta\gamma\delta} a_{\alpha}^{\dagger} a_{\beta}^{\dagger} a_{\delta} a_{\gamma}, \tag{14}$$

where

$$V_{\alpha\beta\gamma\delta} = \langle \alpha(1) | \langle \beta(2) | V_{\text{Coul}}(\vec{r}_1 - \vec{r}_2) | \gamma(1) \rangle | \delta(2) \rangle. \tag{15}$$

In order to simplify this expression and include the effect of screening, we expand $V_{\text{Coul}}(\vec{r}_1 - \vec{r}_2)$ in Fourier series

$$V_{\text{Coul}}(\vec{r}_1 - \vec{r}_2) = \sum_{\vec{q}} V_{\vec{q}} e^{i\vec{q} \cdot (\vec{r}_1 - \vec{r}_2)}, \tag{16}$$

where $V_{\vec{q}} = 2\pi e^2/\kappa_0 Aq$ for a 2D case. Using this expression, we get

$$V_{\alpha\beta\gamma\delta} = \sum_{\vec{q}} V_{\vec{q}} \langle \alpha(1) | e^{i\vec{q}\cdot\vec{r}_1} | \gamma(1) \rangle \langle \beta(2) | e^{-i\vec{q}\cdot\vec{r}_2} | \delta(2) \rangle. \tag{17}$$

To include screening by carriers in graphene, we replace $V_{\vec{q}}$ with $V_s(\vec{q},\omega) = V_{\vec{q}}/\varepsilon(\vec{q},\omega)$, where the dielectric function

 $\varepsilon(\vec{q},\omega)$ in the random phase approximation is given by the Lindhard formula,

$$\varepsilon(\vec{q},\omega) = 1 - V_{\vec{q}} \Pi^{0}(\vec{q},\omega), \tag{18}$$

and the polarizability $\Pi^0(\vec{q},\omega)$ is written as

$$\Pi^{0}(\vec{q},\omega) = \sum_{\alpha\beta} \frac{f_{\alpha} - f_{\beta}}{\epsilon_{\alpha} - \epsilon_{\beta} + \hbar\omega + i\gamma} |F_{\alpha\beta}(\vec{q})|^{2}, \quad (19)$$

with the form factor $F_{\alpha\beta}(\vec{q}) = \langle \alpha | e^{i\vec{q}\cdot\vec{r}} | \beta \rangle$ and γ is the line broadening, which can be attributed to disorder [18]. We use the same value of the line broadening $\gamma = 10^{13} \, \mathrm{s}^{-1}$ here and in all other places where it is included. The value of ω is determined by $\hbar\omega = \epsilon_{\gamma} - \epsilon_{\alpha}$ in $V_{\alpha\beta\gamma\delta}$ [22]. The occupation factors $f_{\alpha,\beta}$ in Eq. (19) are determined self-consistently from the steady-state solutions to the rate equations (36) with screening included.

The rate of the Auger scattering from state $|ab\rangle$ to state $|cd\rangle$ is calculated from Fermi's golden rule, symmetric with respect to the initial and final states:

$$\Gamma_{ab\leftrightarrow cd} = \frac{2\pi}{\hbar} \left| \langle cd|V_C|ab \rangle \right|^2 \delta(\epsilon_c + \epsilon_d - \epsilon_a - \epsilon_b), \quad (20)$$

where the matrix element is

$$\langle cd|V_C|ab\rangle = \frac{1}{2}\left(V_{cdab} - V_{dcab} + V_{dcba} - V_{cdba}\right). \tag{21}$$

Thus there are essentially four terms because electrons are indistinguishable particles. The state $|ab\rangle$ in Eq. (21) means only that both $|a\rangle$ and $|b\rangle$ are occupied, instead of specifying that electron 1 is in $|a\rangle$ and electron 2 is in $|b\rangle$. One can find mistakes in the literature with some of the terms missing.

B. Auger scattering between Landau levels in graphene

For graphene in a transverse magnetic field, an electron state can be written as $|\alpha\rangle = |n_{\alpha}, k_{\alpha}, s_{\alpha}, \xi_{\alpha}\rangle$, with notations explained in Sec. II. We will address the screening effect first. The form factor in Eq. (19) can be evaluated to be

$$F_{\alpha\beta}(\vec{q}) = \langle \alpha | e^{i\vec{q}\cdot\vec{r}} | \beta \rangle$$

$$= \delta_{s_{\alpha},s_{\beta}} \delta_{\xi_{\alpha},\xi_{\beta}} \delta_{q_{y},k_{\alpha}-k_{\beta}} e^{-iq_{x}l_{c}^{2}k_{\beta}} G_{n_{\alpha}n_{\beta}}(q_{y},q_{x}), \quad (22)$$

where we have defined

$$G_{n_{\alpha}n_{\beta}}(q_{y},q_{x}) \equiv \int dx \Phi_{n_{\alpha}}^{\dagger}(q_{y},x)e^{iq_{x}x} \Phi_{n_{\beta}}(0,x). \tag{23}$$

So the polarizability becomes

$$\Pi^{0}(\vec{q},\omega) = \frac{2A}{\pi l_{c}^{2}} \sum_{n_{\alpha}n_{\beta}} \frac{f_{n_{\alpha}} - f_{n_{\beta}}}{\epsilon_{n_{\alpha}} - \epsilon_{n_{\beta}} + \hbar\omega + i\delta} \left| G_{n_{\alpha}n_{\beta}}(q_{y}, q_{x}) \right|^{2}.$$
(24)

One can check that $|G_{n_{\alpha}n_{\beta}}(q_{y},q_{x})|$ depends only on the magnitude of \vec{q} , so $\Pi^{0}(\vec{q},\omega)$ and $V_{s}(\vec{q},\omega)$ are functions only of $q=|\vec{q}|$. We calculated the form factor numerically and checked that it agreed with the analytical expression in [18].

Then, using Eqs. (17) and (30), the Coulomb matrix element is

$$V_{abcd} = \delta_{s_{a},s_{c}} \delta_{s_{b},s_{d}} \delta_{\xi_{a},\xi_{c}} \delta_{\xi_{b},\xi_{d}}$$

$$\times \sum_{\vec{q}} V_{s}(\vec{q},\omega) \delta_{q_{y},k_{a}-k_{c}} e^{-iq_{x}l_{c}^{2}k_{c}} G_{n_{a}n_{c}}(q_{y},q_{x}) \delta_{-q_{y},k_{b}-k_{d}} e^{iq_{x}l_{c}^{2}k_{d}} G_{n_{b}n_{d}}(-q_{y},-q_{x})$$

$$= \delta_{s_{a},s_{c}} \delta_{s_{b},s_{d}} \delta_{\xi_{a},\xi_{c}} \delta_{\xi_{b},\xi_{d}} \delta_{k_{a}+k_{b},k_{c}+k_{d}}$$

$$\times \sum_{q_{x}} V_{s}(\vec{q},\omega) e^{-iq_{x}l_{c}^{2}(k_{c}-k_{d})} G_{n_{a}n_{c}}(q_{y},q_{x}) G_{n_{b}n_{d}}(-q_{y},-q_{x}) \Big|_{q_{y}=k_{a}-k_{c}}.$$

$$(25)$$

For a fixed k_a , this matrix element decays quickly when $k_c - k_a$ is large, since $G_{n_a n_c}(q_y, q_x) X \propto \exp(-(q l_c)^2/4)$ when q is large [18]. If k_c is bounded, then k_b is bounded too; otherwise the term $e^{-iq_x l_c^2(k_c - k_d)}$ would oscillate too fast with q_x , which essentially causes the summation over q_x to vanish.

The Auger scattering rate between two pairs of Landau levels (n_a, n_b) and (n_c, n_d) is

$$\Gamma_{n_a n_b \leftrightarrow n_c n_d} = \frac{1}{2A/\pi l_c^2} \sum_{\xi_a, k_a, s_a} \sum_{\xi_b, k_b, s_b} \sum_{\xi_c, k_c, s_c} \sum_{\xi_d, k_d, s_d} \Gamma_{ab \leftrightarrow cd}$$

$$\times \left(\times \frac{1}{2} \text{ if } n_a = n_b \text{ or } n_c = n_d \right), \tag{26}$$

where the factor 1/2 in the parenthesis is because of double counting the initial or final states. In Eq. (36), one of the summations can be dropped immediately, since the result from the other three summations will be independent of the fourth set of quantum numbers. This summation will give exactly the degeneracy $2A/\pi l_c^2$, so it will cancel with the prefactor. One summation of k can also be eliminated due to the conservation of momentum $k_a + k_b = k_c + k_d$. As the energy is fully quantized, we will replace the δ function in Eq. (20) with a Lorentzian of linewidth γ .

V. PHONON SCATTERING

A. General formulas

The interaction Hamiltonian between phonons and electrons can generally be written as

$$H_{\text{int}}^{\text{ph}} = \sum_{\vec{k}, \vec{q}} F(q) c_{\vec{k} + \vec{q}}^{\dagger} c_{\vec{k}} (b_{\vec{q}} + b_{-\vec{q}}^{\dagger}), \tag{27}$$

where c and c^{\dagger} are annihilation and creation operators for electrons, b and b^{\dagger} are annihilation and creation operators for phonons, and F(q) is defined below. Using Fermi's golden rule, the scattering rate from an initial electronic state $|\varphi_i\rangle$ to a final state $|\varphi_f\rangle$ is

$$\Gamma_{i \to f}^{\text{ph}} = \frac{2\pi}{\hbar} \sum_{\vec{q}} (n_q + 1) |F(q)|^2 |M_{fi}(\vec{q})|^2 \delta\left(\epsilon_f + \epsilon_q^{\text{ph}} - \epsilon_i\right) + \frac{2\pi}{\hbar} \sum_{\vec{q}} n_q |F(q)|^2 |M_{fi}(\vec{q})|^2 \delta\left(\epsilon_f - \epsilon_q^{\text{ph}} - \epsilon_i\right),$$
(28)

where the first term is for the phonon emission, the second term is for the phonon absorption, and the matrix element is given by

$$M_{fi}(\vec{q}) = \langle \varphi_f | \sum_{\vec{k}} c_{\vec{k}+\vec{q}}^{\dagger} c_{\vec{k}} | \varphi_i \rangle$$
$$= \int d\vec{r} \varphi_f^{\dagger}(\vec{r}) e^{i\vec{q}\cdot\vec{r}} \varphi_i(\vec{r}). \tag{29}$$

Using the wave functions in Eq. (2), the matrix element $M_{fi}(\vec{q})$ for $|i\rangle = |n_i, k_i, s, \xi\rangle$ and $|f\rangle = |n_f, k_f, s, \xi\rangle$ is calculated to be

$$\delta_{q_y,k_f-k_i} e^{-iq_x l_c^2 k_i} G_{n_f n_i}(q_y, q_x). \tag{30}$$

The averaged scattering rate from an initial Landau level n_i to a a final Landau level n_f is

$$\Gamma_{n_{i} \to n_{f}}^{\text{ph}} = \sum_{k_{f}} \Gamma_{i \to f}^{\text{ph}}$$

$$= \frac{2\pi}{\hbar} \sum_{\vec{q}} (n_{q} + 1) |F(q)|^{2} |G_{n_{f}n_{i}}(q_{y}, q_{x})|^{2}$$

$$\times \delta(\epsilon_{f} + \epsilon_{q}^{\text{ph}} - \epsilon_{i})$$

$$+ \frac{2\pi}{\hbar} \sum_{\vec{q}} n_{q} |F(q)|^{2} |G_{n_{f}n_{i}}(q_{y}, q_{x})|^{2}$$

$$\times \delta(\epsilon_{f} - \epsilon_{q}^{\text{ph}} - \epsilon_{i}). \tag{31}$$

We will only consider the case of low enough temperatures, when phonon absorption is unimportant and only phonon emission processes contribute to the scattering rate. At room temperature this is still a reasonable approximation; it can be easily dropped if a greater accuracy is needed. We include the screening effect by carriers in graphene in the phonon scattering processes. This can be done by replacing F(q) with $F_s(q,\omega) = F(q)/\varepsilon(q,\omega)$, where the dielectric function $\varepsilon(q,\omega)$ is given in Eqs. (18) and (24), where again the occupation factors are determined self-consistently from the steady-state solutions to the rate equations (36) with screening included.

B. LA phonon scattering

For longitudinal acoustic (LA) phonon scattering, the expression for F(q) is [23]

$$F_{\rm LA}(q) = -\sqrt{\frac{\hbar}{2\rho A v_s}} D\sqrt{q}, \qquad (32)$$

where $\rho=7.6\times 10^{-8}\,\mathrm{g/cm^2}$ is the area mass density of graphene, $v_s=2\times 10^6\,\mathrm{cm/s}$ is the sound velocity, and the deformation potential D is in the $10-50\,\mathrm{eV}$ range. Also, the energy of a LA phonon is $E_q^{\mathrm{LA}}=\hbar v_s q$. By plugging these expressions into Eq. (31), we get the scattering rate by LA

phonons:

$$\Gamma_{n_i \to n_f}^{\text{LA}} = \frac{D^2 q_0^2}{4\pi \rho \hbar v_s^2} \int_0^{2\pi} d\theta \left| G_{n_f n_i}(q_0 \sin \theta, q_0 \cos \theta) \right|^2,$$
(33)

where $q_0 = (\epsilon_{n_i} - \epsilon_{n_f})/\hbar v_s$. The coefficient is of the order of $10^{14} \, \mathrm{s}^{-1}$ for $B \sim 1$ T. However, the integrand in Eq. (33) is roughly of the order of $\exp[-(q_0 l_c)^2/2]$, which is extremely small, since $q_0 l_c \sim \omega_c l_c / v_s = \sqrt{2} v_F / v_s = 50 \sqrt{2}$. Therefore the LA phonon scattering does not contribute significantly to electronic transitions between Landau levels due to a large ratio $v_f / v_s \gg 1$.

C. Surface optical phonon scattering

Since we want to use phonon scattering to our advantage in order to facilitate electron relaxation to the upper laser state, we consider graphene on a polar substrate or sandwiched between two substrates. In this case, the electrons in graphene can couple to the surface or interface modes of optical phonons [15,24], which we will call the surface optical phonons for brevity. If the two substrates on both sides of the graphene layer are the same, the SO phonon energy is equal to the longitudinal optical (LO) phonon energy of the substrate [24]. If there is vacuum on one side, the SO phonon energy is slightly shifted from the LO phonon energy [15]. We will assume the former case for definiteness but note that it would be straightforward to calculate interface optical phonon modes for an arbitrarily complex structure. If we assume that the graphene layer does not affect the SO phonon modes, then the expression of F(q)can be written as

$$F_{SO}(q) = \left[\frac{2\pi e^2 \hbar \omega_{SO}}{A} \left(\frac{1}{\kappa_{\infty}^{\text{sub}}} - \frac{1}{\kappa_{0}^{\text{sub}}} \right) \right] / \sqrt{2q}, \quad (34)$$

where A is the area of graphene, $\kappa_0^{\rm sub}(\kappa_\infty^{\rm sub})$ is the low (high) frequency dielectric constant of the substrate, and $\hbar\omega_{\rm SO}$ is the energy of the surface optical phonon. Since it has a

flat dispersion, we replace the δ functions with a Lorentzian $\mathcal{L}_{\gamma}(E) = \gamma/\pi(E^2 + \gamma^2)$, where γ is the broadening of Landau levels, which again can be attributed to disorder. Using again Eq. (31), we find the SO phonon scattering rate to be

$$\Gamma_{n_{i}\to n_{f}}^{SO} = \frac{1}{2}e^{2}\omega_{SO}\left(\frac{1}{\kappa_{\infty}^{sub}} - \frac{1}{\kappa_{0}^{sub}}\right)\mathcal{L}_{\gamma}\left(\epsilon_{n_{i}} - \epsilon_{n_{f}} - \hbar\omega_{SO}\right)$$

$$\times \int_{0}^{\infty} dq \frac{q^{2}}{\left[q - \frac{2\pi e^{2}}{\kappa_{0}A}\Pi^{0}(q,\omega)\right]^{2}}$$

$$\times \int_{0}^{2\pi} d\theta \left|G_{n_{f}n_{i}}(q\sin\theta, q\cos\theta)\right|^{2}, \tag{35}$$

where the screening effect is included, and $\omega = (\epsilon_{n_i} - \epsilon_{n_f})/\hbar$.

VI. LANDAU LEVEL POPULATIONS UNDER OPTICAL PUMPING

After the expressions for the optical transition rates and the scattering rates due to SO phonon emission and Auger processes have been found, we can write the density matrix equations with adiabatically eliminated optical polarizations to arrive at the set of rate equations for the filling factors of the Landau levels:

$$\frac{d}{dt}f_{n_a} = \frac{d}{dt}f_{n_a}\Big|^{\text{op}} + \frac{d}{dt}f_{n_a}\Big|^{\text{SO}} + \frac{d}{dt}f_{n_a}\Big|^{\text{Auger}}, \quad (36)$$

where

$$\left. \frac{d}{dt} f_{n_a} \right|^{\text{op}} = -\sum_{n_b} \Gamma_{n_a n_b}^{\text{op}} \left(f_{n_a} - f_{n_b} \right), \tag{37}$$

$$\frac{d}{dt} f_{n_a} \Big|^{SO} = -\sum_{n_b} \Gamma_{n_a \to n_b}^{SO} f_{n_a} (1 - f_{n_b})
+ \sum_{n_b} \Gamma_{n_b \to n_a}^{SO} f_{n_b} (1 - f_{n_a}),$$
(38)

and

$$\frac{d}{dt} f_{n_a} \Big|^{\text{Auger}} = \sum_{n_b} t_{n_a, n_b} \times \sum_{n_c} \sum_{n_d \geqslant n_c} \Gamma_{n_a n_b \leftrightarrow n_c n_d} \left[-f_{n_a} f_{n_b} (1 - f_{n_c}) (1 - f_{n_d}) + f_{n_c} f_{n_d} (1 - f_{n_a}) (1 - f_{n_b}) \right], \tag{39}$$

where $t_{n_a,n_b} = 2$ if $n_b = n_a$, and 1 otherwise. Here the subscript op denotes the optical transition rates.

Using these rate equations, we can simulate the dynamics of the graphene system for an arbitrary optical excitation. Note that the system is highly nonlinear, first because of the state filling and second, because the matrix elements depend on the dynamic screening, which depends in turn on the instantaneous distribution of electrons in the Landau levels. Therefore time-dependent simulations are time consuming. Here we present the steady-state results for the continuous-wave optical pumping.

VII. RESULTS AND DISCUSSION

For a GaAs substrate, the SO phonon energy is 36 meV, which requires the magnetic field to be around 1 T. In the simulations, broadenings of all transitions are set to be 5 meV, and T_2 is 0.1 ps. Also, we consider intrinsic (undoped) graphene as an example, so without pumping the n=0 LL is half-filled, all LLs below are fully filled, and all LLs above are empty. We define the gain between n=-1 and -2 as the left-hand side of Eq. (13): $g_{-1,-2}=-(2\pi\omega/\sqrt{\kappa}c)\text{Im}[\chi(\omega_{-1,-2})]$. To minimize the absorption of the THz field by the polar substrate, we would like to reduce

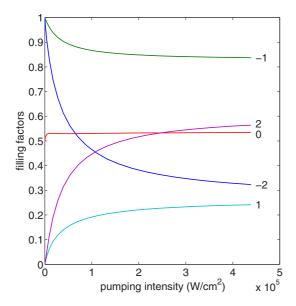


FIG. 4. (Color online) Dependence of the steady-state filling factors on the pumping intensity. Landau level numbers are shown to the right of the curves.

its thickness to a few micrometers to be much smaller than the wavelength of the terahertz field but at the same time, thick enough to be considered bulk for SO phonon scattering. The gain is maximized when there is air outside the active layer so that $\kappa=1$.

The dependence of the steady-state filling factors and gain per graphene monolayer on the pump intensity are shown in Figs. 4 and 5.

As can be seen from the figures, one can achieve a significant steady-state population inversion between states n = -1 and -2 and the gain value of about 0.05 per monolayer of graphene. For comparison, the right-hand side of Eq. (13), which describes mirror losses, is equal to 0.025 when the reflectivities $r_1 = r_2 = 0.95$, which is easily achievable. The closest allowed transition at the \hat{l}_{\ominus} polarization is from n=-3to n = -2 LLs. It is detuned from the laser transition frequency by about 4 meV in a magnetic field of 1 T. Therefore its contribution to losses is lower than the gain. Since the electron motion is quantized, there are no other losses in graphene associated with free carriers. The undoped GaAs is a popular material for the nonlinear terahertz generation and its terahertz losses are rather low, especially since the polar substrate can be thinned down to a few micrometers. Therefore one can operate in the desirable regime where the losses are dominated by mirror losses. Note that the gain of 0.05 is higher than the maximum value of $\pi e^2/(\hbar c) \simeq 0.023$ in graphene without a magnetic field. This is because energy quantization in a magnetic field condenses the continuous density of states into discrete LLs, leading to the maximum gain enhancement scaling as the ratio of the transition frequency to linewidth. One can further scale the gain up by stacking several graphene-on-GaAs lavers.

For surface states in 3D topological insulators such as Bi₂Se₃ or Bi₂Te₃, the Fermi velocity has a similar value but

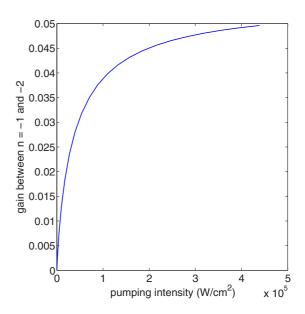


FIG. 5. (Color online) Dependence of the gain between n = -1 and -2 LLs per graphene monolayer on the pumping intensity.

there is no spin or valley degeneracy. Therefore a similar laser scheme with a thin film of Bi₂Se₃ (i.e., two surfaces) placed on a polar substrate will give about two times smaller gain. Additional free-carrier terahertz losses may exist in this case due to unintentional doping of the bulk Bi₂Se₃.

One can also see in Fig. 4 that the population inversion exists also between states n=2 and 1, albeit at a 2 times lower level. This seems unexpected, given that the optical pumping brings carriers only to state 1. However, a closer look at the rate equations shows that the population inversion between levels 1 and 2 is a consequence of a strongly nonequilibrium carrier distribution below the Fermi level created by the optical pumping, namely, the population inversion between states -2 and -1. Indeed, when $f_{-1} > f_{-2}$, the Auger scattering rate from states (1,-1) to states (2,-2) is greater than the scattering rate in the opposite direction. This creates the population inversion $f_2 > f_1$ and the gain for the \hat{l}_{\oplus} polarization, which is about two times smaller than the \hat{l}_{\ominus} gain.

In conclusion, we show the feasibility of the Landau level terahertz laser in a magnetized graphene. Despite ultrafast Auger relaxation, steady-state operation of the laser under continuous-wave optical pumping is possible by utilizing surface or interface phonon relaxation. The scheme is scalable to thin films of 3D topological insulators such as Bi₂Se₃ or Bi₂Te₃.

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